



Supplementary Materials Reactive Infiltration and Microstructural Characteristics of Sn-V Active Solder Alloys on Porous Graphite

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1. Characterization of Solidified Sn-V Alloys

Figure S1 shows the cross-sectional microstructure of Sn-1/3/5V alloys/graphite wetting samples solidified from 950 °C. Viewing from the optical and SEM images, V and Sn formed Sn-V intermetallics (IMCs) in the droplet during wetting and the amount of Sn-V IMCs increased with the increase of V content. The EDS analysis and Sn-V phase diagram showed that the Sn-V IMCs in the solidified Sn droplet was mainly composed of VSn₂. The refractory VSn₂ formed in the center of Sn droplet would impede the fluidity of Sn-V alloy to a certain extent and result in the formation of a flat platform at the top of Sn-V alloy under the condition of high V content.



Figure S1. The cross-sectional microstructure of Sn-1/3/5 alloy/graphite samples cooling from 950 °C.

2. Characterization of Reaction Product at Sn-V Alloys/Graphite Interface

Figure S2 shows the cross-sectional microstructure of the reaction interfaces at the center of solidified Sn-V alloys after wetting at 950 °C. EDS analysis suggested that the vanadium carbides

layer was formed adhering to the graphite, which was a barrier for the infiltration of liquid Sn. Moreover, when the V content increased to 3–7 wt.%, a layer of V₃Sn was formed adhering to the vanadium carbides.



Figure S2. Cross-sectional SEM images of the reaction interfaces at the center of droplet of (**a**) Sn-0.5V, (**b**) Sn-1V, (**c**) Sn-3V, (**d**) Sn-5V, and (**e**) Sn-7V.

Figure S3 shows the XRD patterns acquired at the reaction interfaces between Sn-0.5/3/7V alloys and graphite after wetting at peak temperature of 950 °C. By matching the peak positions with the standard XRD spectra, V₂C, V₈C₅ or V₆C₅ peaks are detected, which indicated the reaction layer was composed of V₂C, V₈C₅ or V₆C₅. Furthermore, the original V content had a limited influence on the composition of the reaction layer.



Figure S3. XRD patterns obtained at the interface between Sn-0.5/3/7V alloy and graphite after wetting at 950 °C, inserted with the top-view of Sn-3V/graphite wetting sample after deeply etching.

Figure S4 shows the XRD patterns acquired at the reaction interfaces between Sn-3V alloy and graphite after isothermal wetting at 750, 800, 850, and 900 °C. Similarly, the reaction layer was composed of V₂C, V₈C₅ or V₆C₅ according to the peak positions shown in Figure S4.



Figure S4. XRD patterns obtained at the reaction interfaces between Sn-3V alloy and graphite after wetting at 750, 800, 850 and 900 °C. The residual Sn-V alloys at the reaction interface were removed by an HCl solution.



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